Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/528,218	DOUVILLE ET AL.
Examiner	Art Unit
Bin Shen	1657

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SEARCHED						
Class	Subclass	Date	Examiner			
NA	NA	1/10/2007	BS			
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH N (INCLUDING SEARC		·)
	DATE	EXMR
WEST-see printout.	1/10/2007	BS
Priority document checked.	1/10/2007	BS
Inventor name searched.	1/10/2007	BS
SEQ search: NA.	1/10/2007	BS